

## Experiment Proposal

Experiment number GP2022013

<b>Principal investigator</b>	Professor Alessandro Cianchi, University of Rome Tor Vergata, ITALY
<b>Co-investigator</b>	Professor Carla Andreani, University of Rome Tor Vergata, ITALY
<b>Co-investigator (*)</b>	Professor Enrica Chiadroni, Sapienza University of Rome, ITALY
<b>Co-investigator</b>	Dr Luigi Faillace, INFN-LNF Frascati, Rome, ITALY
<b>Co-investigator</b>	Dr Mario Galletti, Università di Roma Tor Vergata, ITALY
<b>Co-investigator</b>	Dr Andrea Liedl, INFN, ITALY
<b>Co-investigator</b>	Dr Riccardo Pompili, INFN, ITALY
<b>Co-investigator</b>	Dr Giovanni Romanelli, University of Rome Tor Vergata, ITALY
<b>Experiment title</b>	Elemental and surface characterization of cathodes for photoinjectors
<b>SRF Instrument</b>	<b>Scanning Probe Microscopes</b>
<b>Access Route</b>	Rapid Access
<b>Science Areas</b>	Materials, Physics, Technique Development
<b>Sponsored Grant</b>	None
<b>Grant Title</b>	-
<b>Start Date</b>	-
<b>Similar Submission?</b>	-
<b>Industrial Links</b>	-

**Days requested:** 2  
**Previous GP Number:** -  
**DOI:** -  
**Sponsor:** -  
**Grant Number:** -  
**Finish Date:** -

**Non-Technical Abstract**

High brightness machines, like Free Electron lasers, are driven by photoinjectors. The quality of the electron beam extracted from the source is paramount for the whole machine's performance.

Copper cathodes are widely used, as electron sources, for their reasonable quantum efficiency, robustness, simple treatment, and implementation. However, copper cathodes, exposed to strong electric fields and continuously bombarded with high-intensity lasers, can degrade their quantum efficiency for several reasons. The most common problem is surface contamination, mainly due to carbon ions, but also thermal stress can induce dislocations inside the material that leads to extrusion, creating a tip where the electric field can grow up, leading to a dangerous discharge.

The change in quantum efficiency or, even worse, the difference in this parameter point by point can dramatically affect the beam properties, degrading the emittance and producing poor radiation source performances.

To this end, we propose performing an experiment to precisely analyze the material surface and bulk properties to understand all these features better, comparing cathodes before and after their usage inside an RF gun.

The investigation will include a technique to monitor the surface morphology, using SEM like the Tescan Vega SEM-EDX (Scanning Probe Microscope) SRF of ISIS@MACH ITALIA, to see the signature of potential damages induced by arc discharges, and with EDS to show possible surface contaminants. Also, all the instrumentation to monitor the bulk properties and lattice stress should be applied, relying on X-rays or neutrons.

**Publications**

-

**Instruments**  
**Access Route**  
**Science Areas**  
**Sponsored Grant**  
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**Finish Date:**



## Sample record sheet

**Principal contact** Professor Enrica Chiadroni, Sapienza University of Rome, ITALY  
**SRF Instrument** **Scanning Probe Microscopes** **Days Requested: 2**  
**Special requirements:**

### SAMPLE

<b>Material</b>	Cu Oxygen free 99.95% exposed to RF	Cu Oxygen free 99.95% not exposed to RF	-
<b>Formula</b>	Cu	Cu	-
<b>Forms</b>	Solid	Solid	
<b>Volume</b>	60 cc	60 cc	
<b>Weight</b>	0.5 Kg	0.5 mg	
<b>Container or substrate</b>	-	-	-
<b>Storage Requirements</b>	Inert gas	Inert gas	-

### SAMPLE ENVIROMENT

<b>Temperature Range</b>	- K	- K	-
<b>Pressure Range</b>	- mbar	- mbar	-
<b>Magnetic field range</b>	- T	- T	-
<b>Standard equipment</b>	None	None	-
<b>Special equipment</b>	Sample to store in inert gas	-	-

### SAFETY

<b>Prep lab needed</b>	Yes	Yes	-
<b>Sample Prep Hazards</b>	-	-	-
<b>Special equip. reqs</b>	-	-	-
<b>Sensitivity to air</b>	Yes	Yes	-
<b>Sensitivity to vapour</b>	Yes	Yes	-
<b>Experiment Hazards</b>	-	-	-
<b>Equipment Hazards</b>	-	-	-
<b>Biological hazards</b>	-	-	-
<b>Radioactive Hazards</b>	-	-	-
<b>Additional Hazards</b>	-	-	-
<b>Additional Details</b>	-	-	-
<b>Sample will be</b>	Removed By User	Removed By User	-

